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# Structural and Magnetic Properties of $\text{Fe}_x\text{Cu}_{1-x}$ Sputtered Thin Films Electrochemically Treated To Create Nanoporosity for High-SurfaceArea Magnetic Components

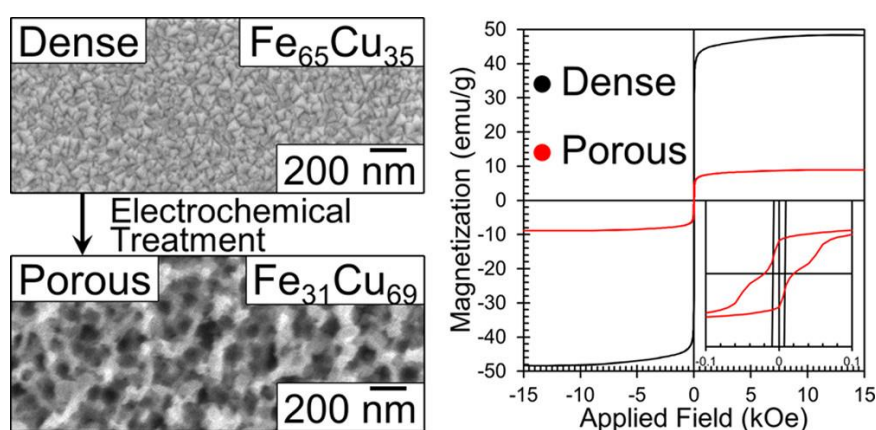
Shauna Robbennolt,<sup>\*,†</sup> Jordina Fornell,<sup>†</sup> Alberto Quintana,<sup>†</sup> Huiyan Zhang,<sup>†</sup> Enric Menendez,<sup>†</sup> Eva Pellicer,<sup>\*,†</sup> and Jordi Sort<sup>\*,†,‡</sup>

<sup>†</sup> Departament de Física, Universitat Autònoma de Barcelona, E-08193 Bellaterra, Spain

<sup>‡</sup> Institució Catalana de Recerca i Estudis Avançats (ICREA), Pg. Lluís Companys 23, E-08010 Barcelona, Spain

**ABSTRACT:** Sputter deposition is a facile and widely used technique for fabricating thin-film materials. Electrochemical dealloying, on the other hand, is a promising method for creating nanoporosity, and therefore increasing surface area, in metallic materials. Surprisingly, little work has been done on the application of electrochemical dealloying to sputter-deposited thin films. Here, we prepare  $\text{Fe}_x\text{Cu}_{1-x}$  thin films by sputter deposition to be then electrochemically treated to create porosity. We investigate the structural and magnetic properties of as-sputtered and electrochemically treated films. We find that the morphology, crystal structure, and magnetic properties are highly dependent on initial film composition. For high copper content films ( $\text{Fe}_{29}\text{Cu}_{71}$ ), relative Cu content is found to decrease during the dealloying process. For these films, the crystal structure is not greatly affected by the induced porosity and the porous films show increased saturation magnetization. However, for the more Fe-rich compositions ( $\text{Fe}_{63}\text{Cu}_{37}$ ), we find that Fe is preferentially lost and making the films nanoporous induces a crystal structure change from body-centered cubic (bcc) to a mixture of face-centered cubic (fcc) and bcc phases. These same porous films show a decrease in saturation magnetization and a large increase in coercivity compared to the as-sputtered films. These films are attractive as high-surface-area magnetic components because of the tunability of their magnetic properties and their high surface area due to porosity. To the best of our knowledge, these results constitute the first example of nanoporous, magnetic thin films by prepared by sputtering and subsequent electrochemical treatment.

**KEYWORDS:** nanoporous, magnetron sputtering, FeCu, magnetic thin films, electrochemical dealloying



## 1. INTRODUCTION

Materials with 3D nanoporosity have attracted significant research interest. Because of their porosity, these materials have a large surface area, which is useful for applications ranging from catalysis<sup>1–9</sup> to energy storage.<sup>2,4,10–13</sup> In the case of catalysis, nanoporous magnetic materials are particularly attractive because they are magnetically recoverable. Despite the advantages of nanoporous materials, they are not currently widely used commercially, partly due to the limitations of current fabrication methods. A common method to prepare porous materials is to use a sacrificial templating agent such as polymers, surfactants (soft templating), porous silica, or anodic alumina (hard templating).<sup>7,14–20</sup> In these cases, the material is grown in or around the template which is then removed, leaving pores in its place. Although effective in a research setting, these methods are not very scalable and often require reasonably expensive templates.

Among corrosion methods, electrochemical dealloying is a promising technique for fabricating nanoporous metals in a scalable manner without the need for a sacrificial template.<sup>3,21–25</sup> Electrochemical dealloying is a method for forming a porous metal or metal alloy by selectively dissolving the most electrochemically active element in an alloy. It is important to note that this type of electrochemical dealloying is highly dependent on composition. If the fraction of the nobler element (i.e., the less electrochemically active element) is too high, above what is called the “parting limit”, both elements are then removed. On the other hand, if the fraction of the nobler element is too low, then as the dealloying progresses, there is insufficient noble element available for passivation, and the entire structure can dissolve or collapse.<sup>10,26</sup> This technique has been used on bulk metals,<sup>21–24,26</sup> ribbons,<sup>3</sup> as well as thin films made by a variety of methods such as electrodeposition,<sup>27</sup> electron beam deposition,<sup>28</sup> and sputter deposition.<sup>29</sup> Of particular interest is the application of electrochemical dealloying to create porosity in sputtered films. Sputtering is a highly effective and industrially scalable technique that is widely used to produce thin films. However, there are very few examples of porous films being made directly via sputtering alone.<sup>30,31</sup> In some systems, porosity can be induced, but only to some extent and in a rather inhomogeneous manner, by tuning the Ar<sup>+</sup> gas pressure in the sputtering chamber or the deposition angle during the growth of the films.<sup>30,31</sup> Combining sputter deposition with electrochemical dealloying could therefore be a promising route to fabricate homogeneous porous thin films in a facile and reproducible way.

Here we have investigated the structural and magnetic properties of Fe<sub>x</sub>Cu<sub>1-x</sub> ( $31 \leq x \leq 73$ , at %) thin films fabricated in this manner. Fe<sub>x</sub>Cu<sub>1-x</sub> is an attractive material system to study both because it is magnetically soft and made from earth-abundant elements making it useful in sustainable devices. In addition, previous theoretical studies have suggested that Cu can force the Fe into the face-centered cubic (fcc) structure, which can lead to a higher magnetic moment per Fe atom than in body-centered cubic (bcc)-Fe alone.<sup>32–34</sup> We investigated the structural and magnetic properties of both as-sputtered films as well as those made porous using a corrosive electrochemical treatment, as shown in Scheme 1. For a detailed investigation, we focused on two types of samples: high copper content films with an entirely fcc structure and films with a mixed fcc/ bcc structure.

## 2. EXPERIMENTAL METHODS

2.1. Preparation of Sputtered Films. Thin films were prepared by cosputtering Fe and Cu at room temperature in an AJA International, Inc. magnetron sputtering system. Clean Si substrates (5 × 7 mm<sup>2</sup>) were mounted and then the chamber was put under vacuum overnight to achieve a pressure  $\sim 1 \times 10^{-7}$  torr. The Fe was always sputtered at a power of 200 W (direct current, DC)

and the Cu was sputtered at various powers (40, 80, 120, 160, 200, and 240 W, alternating current, AC) for 15 min resulting in thin films with thicknesses between 200 and 300 nm.

2.2. Electrochemical Treatment. The films were treated using an Autolab potentiostat/galvanostat in a 3-electrode configuration. The electrolytic solution was dilute nitric acid in water with acid concentrations ranging from 10 mM to 60 mM. The sputtered films were used at the working electrode with half of the film submerged in the electrolyte. The counter electrode was a platinum wire and the reference electrode was Ag/AgCl (3 M KCl) with 20 mM nitric acid as the exterior solution. All potentials are referred to this electrode. The films were treated at +0.5 V for 60 s. The films were quickly removed from the solution and subsequently rinsed with distilled water and dried. The entire procedure was conducted in air. For characterization, the films were cut using a diamond scribe to remove the half of the film that was not submerged in the electrolyte solution, leaving just the electrochemically treated half.

2.3. Characterization. X-ray diffraction (XRD) patterns were collected on a Philips X'Pert diffractometer using Cu K $\alpha$  radiation. Field-emission scanning electron microscope (FE-SEM, Zeiss Merlin) with energy-dispersive X-ray spectroscopy (EDX) capabilities was used to characterize the microstructure of the films and the elemental composition. X-ray photoelectron spectroscopy (XPS) analysis was performed using a PHI 5500 multitechnique system (Physical Electronics) with a monochromatic Al K $\alpha$  source under ultrahigh vacuum. XPS scans were done both on the surface as well as after 15 s of Ar<sup>+</sup> sputtering to remove any surface contaminants. The magnetic properties were measured using a MicroSense vibrating sample magnetometer (VSM). The sample magnetization of the VSM data was normalized, in some cases, by mass as determined by inductively coupled plasma (ICP) spectroscopy. The ICP was done on an ICPE 9000 from Shimadzu by dissolving each sample in 3 mL in a 1:1 solution of water and nitric acid (68%).

### 3. RESULTS AND DISCUSSION

Thin films of Fe<sub>x</sub>Cu<sub>1-x</sub> with various compositions were grown using magnetron cosputtering as described above. The elemental composition of the films was determined using EDX and the crystal structure was probed using XRD, as shown in Figure 1a. As expected, the films with the highest Cu content, Fe<sub>31</sub>Cu<sub>69</sub> (purple line), were found to have a facecentered cubic (fcc) structure, which is consistent with the native fcc structure of copper. The films with the highest Fe content, Fe<sub>73</sub>Cu<sub>27</sub> (black line), were found to have a bodycentered cubic (bcc) structure, consistent with the native structure of iron. Films with the intermediate composition of Fe<sub>57</sub>Cu<sub>43</sub> (red line), showed both fcc and bcc peaks indicating that both phases coexist in this case. The magnetic properties of these films were investigated using VSM and the resulting M-H loops are presented in Figure 1b. As expected, the magnetic moment at saturation (M<sub>S</sub>), remanent magnetization (M<sub>R</sub>), and coercivity (H<sub>C</sub>) all increase with increasing Fe content.

Moving forward, we chose to focus on two compositions for electrochemical treatments: the highest Cu content fcc films (Figure 1, purple lines), and the films showing both fcc and bcc structure (Figure 1, red lines). The films were treated at +0.5 V for 60 s in aqueous solutions of nitric acid with various concentrations (10–60 mM). We also attempted to investigate films that showed only bcc structure (Figure 1, black lines), but were unable to successfully dealloy them. We believe that this was because the films were too Fe-rich and outside of the concentration range suitable for dealloying. For these two samples, we used both XPS and ICP in addition to EDX in order to determine the composition. The ratio of Fe:Cu was determined by all of these techniques and is now indicated in Table 1. As shown, there are differences in compositions as determined by the various techniques which is due to inherent differences in the techniques. For example, XPS is known to only probe the surface and is therefore viewed as indicative of the surface composition only. However, XPS is also the only technique used that can accurately

quantify oxygen content. Furthermore, EDX and XPS are known to have high errors, which is why we conducted ICP. In an effort to be as accurate as possible, we have decided to use the ICP determined composition in referring to the samples from this point forward, and discuss the XPS composition only as it relates to oxygen content.

Figure 2 shows top-view scanning electron microscopy (SEM) images of the high Cu content films (Fe<sub>29</sub>Cu<sub>71</sub>) both as-sputtered (a) and after electrochemical treatment (b–e). The as-sputtered films appear to be composed of fairly round particles and the structure does not seem to be altered by treatment in 10 or 20 mM nitric acid. However, films treated with 40 and 60 mM (d, e) nitric acid are seen to have a distinct porous structure.

The elemental composition and surface oxidation state of the as-sputtered films and porous films (after treatment in 40 mM nitric acid) was determined using XPS as shown in Figure 3. In these experiments, the surface of the films was first etched for 15 s with Ar<sup>+</sup> ions in order to remove the outermost layer of atoms and surface contaminants from handling the films in air. We expect that the etching rate is approximately 7 nm/min, so the 15 s of etching should have removed only Fe oxides on the surface, but the peak values are shifted to slightly higher binding energies than literature reports for pure Fe which could be due to the formation of an Fe–Cu solid solution. On the other hand, in the spectrum of the porous film the peak positions match those reported for pure Fe and Fe oxides.<sup>2,5,20,35</sup> Here, we find a small contribution from Fe<sub>0</sub> (blue peaks), and significant contributions from Fe<sup>2+</sup> and Fe<sup>3+</sup> (purple and green peaks). In the case of the Cu spectra, only Cu<sub>0</sub> is found for both the as-sputtered and porous films which is consistent with the fact that Cu is the more noble metal.

The surface composition was determined from XPS and the results are presented in Figure 3. The as-sputtered film is found to have less oxide (17 at %) than the porous film (28 at %). The films were handled and stored in air prior to the XPS measurements, so we expect that a passivation oxidation layer was formed at the film surface, which is why such high oxygen content was determined by XPS. Discounting the oxygen content, the films are found to become more Fe-rich after the electrochemical treatment. The as-sputtered films were found to be Fe<sub>25</sub>Cu<sub>75</sub> (Fe<sub>31</sub>Cu<sub>69</sub> by ICP) while the porous films were found to be Fe<sub>78</sub>Cu<sub>22</sub> (Fe<sub>83</sub>Cu<sub>17</sub> by ICP). As described above, typically in electrochemical dealloying, the more electrochemically active element, in this case iron, should be predominantly removed. However, at high concentrations of the more noble element, above what is referred to as the parting limit, both elements are removed simultaneously. Our results reveal that the relative amount of Cu became lower, which suggests that this composition was above the parting limit.

The structure and magnetic properties of these films were investigated with XRD and VSM, as shown in Figure 4. The XRD diffractograms in Figure 4a show that the films all have an fcc structure and there is no observed change in crystallographic structure as a result of the electrochemical treatment. Despite the increase in Fe content upon dealloying, the fact that the films remain purely fcc structurally is interesting, but consistent with previous reports that the fcc structure can be stabilized in Fe–Cu films up to ~80% Fe.<sup>36</sup> It is worth noting that there are no iron or copper oxide peaks detectable in the XRD patterns, which suggests that the inner parts of the films are metallic, and that the oxide detected by XPS is only present on the surface. In addition, we used high resolution transmission electron microscopy (TEM) and selected area electron diffraction (SAED) to further characterize the crystal structure of the films and have included that data in Figures S2 and S3. In spite of slight oxidation (as revealed by the SAED patterns) is significant that these films contain a large fraction of metallic phases after dealloying (as evidenced by XRD), particularly because there are no noble metals here. Many previous reports have successfully used dealloying to make porous metals with noble metal alloys (Pt, Au, etc.),<sup>22,25,26,37,38</sup> but often with nonnoble elements, dealloying causes oxidation.<sup>21,27,39,40</sup>

The inplane M–H loops for these films are shown in Figure 4b. The films treated at 10 and 20 mM nitric acid have almost identical properties to the as-sputtered films whereas the porous films, those treated with 40 and 60 mM nitric acid, have a higher HC and MS. We note that the loops for the films treated with 40 and 60 mM nitric acid are noisier because those films had less total amount of material and thus lower signal. Because all of the films show the same fcc structure, the changes in magnetic properties could be attributed to either the change in elemental composition and/or the porosity. In this case, we expect that both factors could increase the coercivity. The dealloying process made the films more Fe-rich, which would increase the coercivity and the induced porosity could have the same effect by limiting domain wall propagation. Because both factors could have caused the increase in coercivity, it is difficult to determine the exact cause, although we believe the increased coercivity was due to a combination of these factors. Next, we investigated the effects of the electrochemical treatment on the films showing both fcc and bcc structure (Figure 1, red lines). Figure 5 shows the top-view SEM images of these films both as-sputtered (a) and after electrochemical treatment (b–d). Similar to the high Cu content films, the films treated with 10 and 20 mM nitric acid (b, c) show little to no change in morphology compared to the as-sputtered films. The films treated with 40 mM nitric acid (d), however, show significant porosity and a loss of the particulate structure. Instead, the occurrence of a 3D network with ligament size of 50–100 nm was evident. Note that films of this composition could not be treated with 60 mM nitric acid without significant delamination/dissolution. Figure 6 shows the results of the XPS analysis for these films and the calculated surface composition. The Fe spectra of the as-sputtered film shows that the surface Fe is entirely oxidized while the surface Fe in the porous film has a significant contribution from Fe<sup>0</sup> (blue peaks). For both the as-sputtered film and the porous film, the Cu is found to be entirely metallic. This is similar to the results for the high Cu content films. The porous film is again more oxidized than the as-sputtered film with 28 at % oxygen compared to 21 at % oxygen in the as-sputtered film. These films, unlike the previous ones, lost Fe during the electrochemical treatment to become more Cu-rich. Disregarding oxygen, the as-sputtered films were found to be Fe<sub>64</sub>Cu<sub>36</sub>, whereas the porous film was Fe<sub>31</sub>Cu<sub>69</sub> after etching. These results are consistent with an electrochemical dealloying process below the parting limit.<sup>8,23,26,38</sup>

Figure 7a shows the XRD diffraction patterns for these films. In the as-sputtered films, the bcc peak is larger than the fcc peak, but after electrochemical treatment the fcc peak increases relative to the bcc peak. This is consistent with the composition change because Cu promotes the fcc structure and, as iron is removed and the films become more Cu-rich, there is larger content of the fcc phase present. This points to diffusion of the Cu adatoms during the dealloying treatment.<sup>8</sup> Figure 7b shows the in-plane M–H loops for these films. The as-sputtered film (black line) has the highest MS and MR followed by the films treated with 10 and 20 mM nitric acid (blue and green lines). The porous film (red line) is found to have the lowest MS and a slightly higher HC. The reduction in MS is attributed to the change in composition (i.e., reduction in Fe fraction). However, a reduction of Fe content would be expected to decrease the HC, whereas here, the coercivity is increased. Therefore, we attribute the increased coercivity in this case to the induced porosity and the change in crystal structure. Furthermore, this loop has an obvious step in it (i.e., a staircase-like shape), which suggests that there are two distinct contributions to the magnetism. While it is unclear exactly what is causing this step, we believe that the second contribution (with higher coercivity) could be from the newly formed fcc phase, in agreement with the XRD data. It is possible that a partially oxidized metal could produce similar data, but in this case, it is unlikely that oxidation is causing the step because XRD in Figure 7a suggests that the films are primarily metallic. Another possible cause of this step is that the dealloying process created porosity through most, but not all, of the film thickness, which was determined by looking at cross sections in SEM (included in Figure S1). It is possible that the two contributions are the porous component and the pristine layer underneath. However, we do not believe this

this the primary cause of the step because the same underlayer is present in the Cu-rich films (also in Figure S1), and in that case, there is no step in the hysteresis loop (Figure 4). It is for these reasons that we believe that the cause of the dual contributions is the presence of both fcc and bcc phases in these films, whereas in the fcc only films, only a single magnetic contribution is observed. This is consistent with work previously published by our group on FeCu films deposited by electrodeposition which found that films with increased fcc contributions had higher coercivities.<sup>41</sup>

We further investigated the in-plane and out-of-plane magnetization curves for both as-sputtered films and the porous films (Figure 8). The  $M-H$  applied loops of the high Cu content films (Fe<sub>29</sub>Cu<sub>71</sub>) are shown in Figure 8a. Both the as-sputtered (black lines) and porous (red lines) films were found to be isotropic with very little difference between the in-plane (solid lines) and out-of-plane (dashed lines) loops. However, the films with mixed fcc and bcc structure (Fe<sub>63</sub>Cu<sub>37</sub>) in Figure 8b were found to be anisotropic. For both the as-sputtered (black lines) and porous (red lines) films MR and HC are all found to be higher in the in-plane direction (solid lines). We believe that this could be due to the Cu rich films being made of magnetic clusters, not necessarily interconnected, so that the in-plane shape anisotropy is not observed. That is, if the magnetic component is primarily made of randomly oriented clusters then we expect the magnetism to be the same in all directions (i.e., no shape anisotropy). Conversely, the ferromagnetic regions in the Fe<sub>63</sub>Cu<sub>37</sub> films are likely to be more abundant and interconnected, which would make them behave more like a typical magnetic thin film than clusters. In this case, we would expect the demagnetizing field to be larger, leading to clear in plane shape anisotropy.

#### 4. CONCLUSIONS

Here we have reported the fabrication of Fe<sub>x</sub>Cu<sub>1-x</sub> thin films by cosputtering and the characterization of their magnetic properties. We have also presented a method for creating nanoporosity in these films using a corrosive electrochemical treatment. Remarkably, the fabrication of nanoporous thin films by combining sputter deposition with electrochemical treatments has been largely overlooked in the literature. Hence, this work constitutes one of the first studies on nanoporous magnetic thin films made using these methods. This is of particular interest for use in high-surface-area magnetic components because the induced porosity creates a high surface area, whereas the magnetic properties are highly tunable through composition. We found that the microstructure, crystal structure and magnetic properties of these films are all dependent on both initial film composition as well as porosity. Furthermore, the methods developed here can be applied to other systems to create porous magnetic thin films with tunable structural and magnetic properties.

#### AUTHOR INFORMATION

Corresponding Authors

\*E-mail: shaunaaryn.robennolt@uab.cat (S.R.).

\*E-mail: eva.pellicer@uab.cat (E.P.).

\*E-mail: jordi.sort@uab.cat (J.S.).

ORCID

Shauna Robbennolt: 0000-0001-5723-7971

Alberto Quintana: 0000-0002-9813-735X

Enric Menendez: 0000-0003-3809-2863

Notes The authors declare no competing financial interest.

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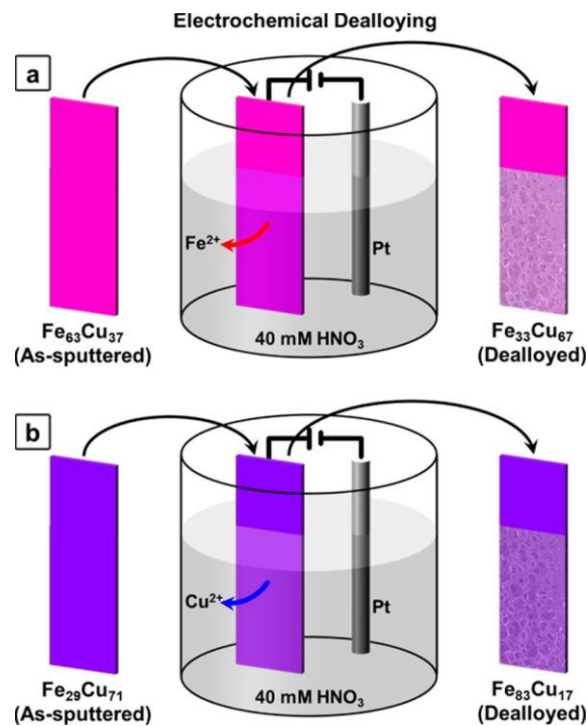
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FIGURES



Scheme 1. Cartoon Representing the Electrochemical Dealloying Step Using the 40 mM  $\text{HNO}_3$  Solution, against a Pt Reference Electrode: (a) High-Fe Film Predominantly Loses Fe, Becoming More Cu-Rich ; (b) High-Cu Films Predominantly Lose Cu, Becoming More Fe-Rich.

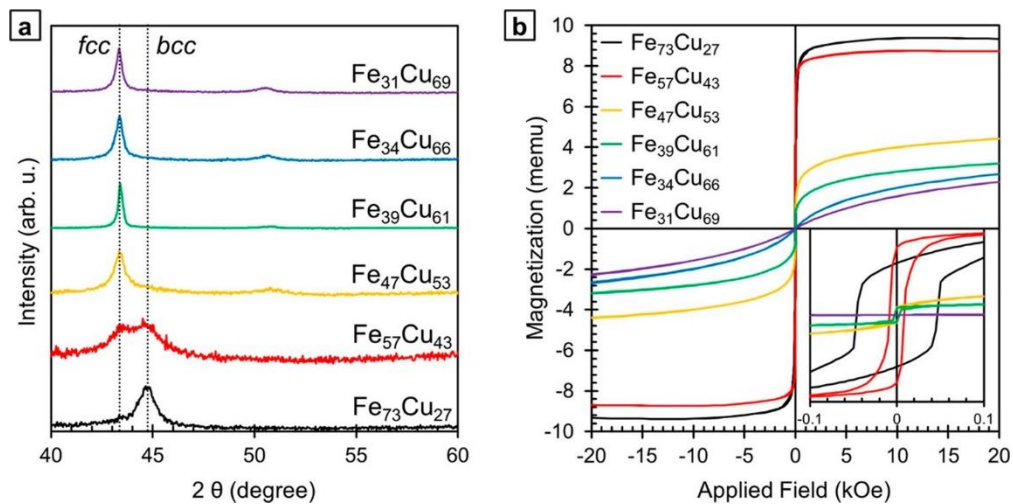


Figure 1. (a) XRD diffraction patterns of as-sputtered films of various compositions (as determined by EDX analysis). (b) In-plane magnetic hysteresis loops of as-sputtered films of various compositions. Inset shows the loops zoomed into the low applied field region. Note that for these samples, the sample size was kept constant, so that the magnetic moment values can be compared even if they are not normalized by volume or mass.

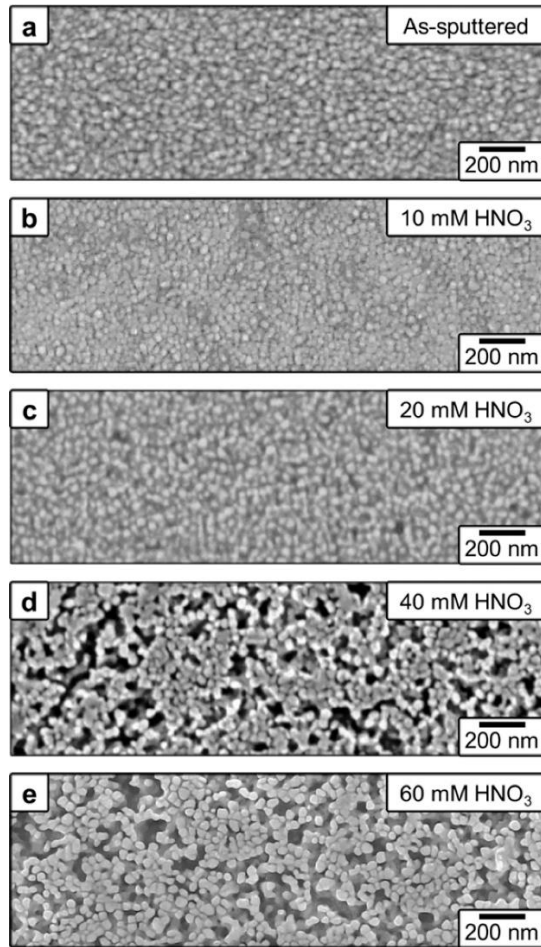


Figure 2. Top-view SEM micrographs of  $\text{Fe}_{29}\text{Cu}_{71}$  films (a) as-sputtered and after treatment for 60 s at +0.5 V in (b) 10 mM  $\text{HNO}_3$ , (c) 20 mM  $\text{HNO}_3$ , (d) 40 mM  $\text{HNO}_3$ , and (e) 60 mM  $\text{HNO}_3$ .

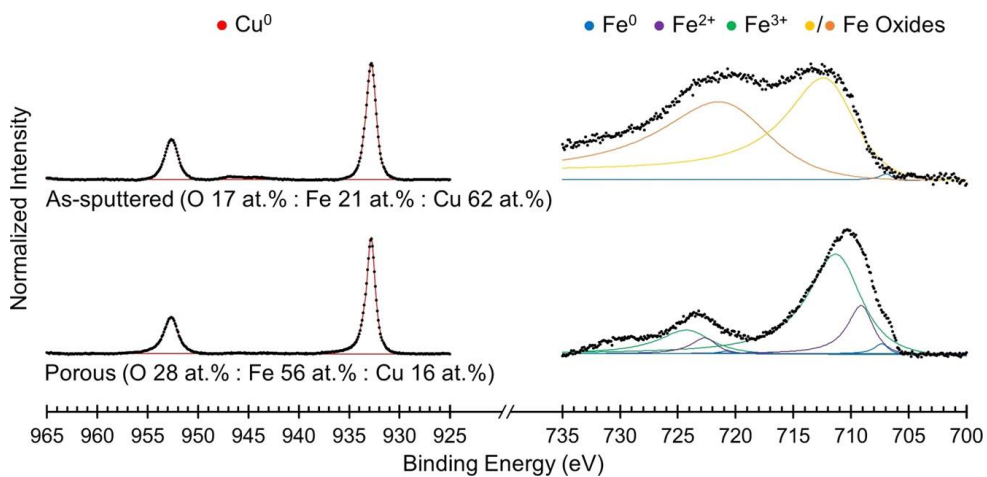


Figure 3. Cu and Fe XPS spectra of high-Cu-content films with fits. Measurements were taken after 15 s of  $\text{Ar}^+$  etching to remove surface contaminants. Black dots correspond to raw data points, whereas colored lines are fitted peaks color coded to correspond to oxidation state. Different oxidation states were assigned according to literature reports found using the NIST XPS database. [\(2,4,7,20,35\)](#)

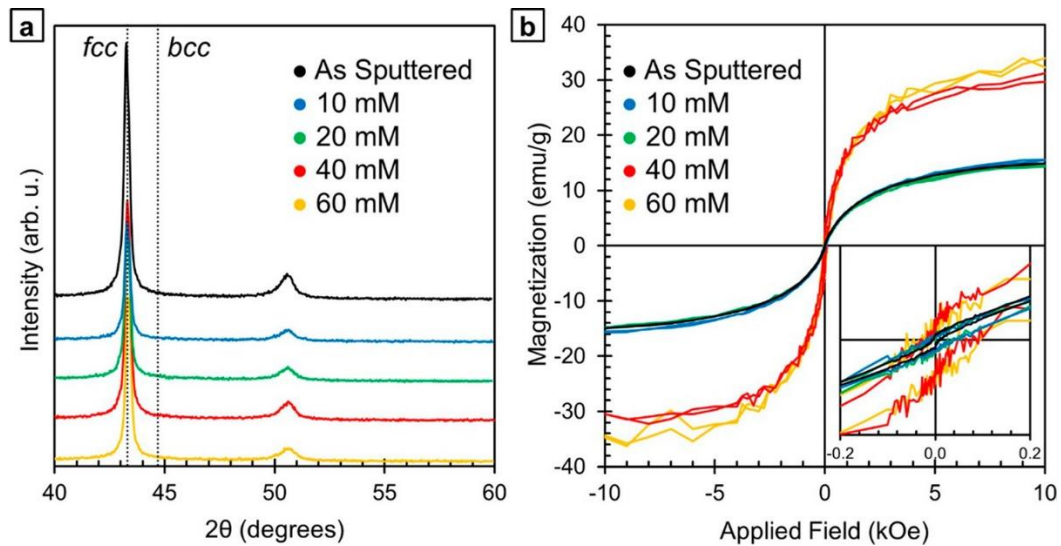


Figure 4. (a) XRD diffractograms of  $\text{Fe}_{29}\text{Cu}_{71}$  films both as-sputtered (black) and after treatment at +0.5 V for 60 s in various concentrations of nitric acid (10 mM, blue line; 20 mM, green line; 40 mM, red line; 60 mM, yellow line). (b) In-plane magnetic hysteresis loops of the same films. Inset shows the loops zoomed into the low-applied-field region.

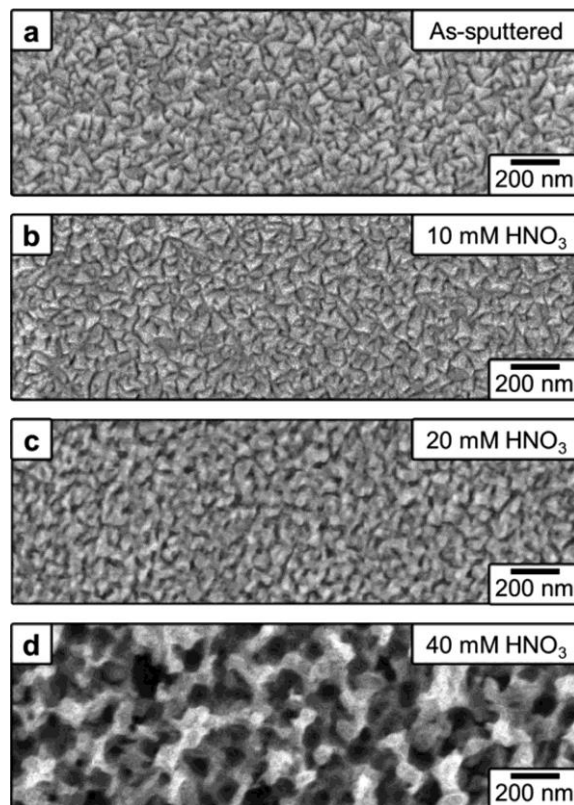


Figure 5. Top-view SEM micrographs of  $\text{Fe}_{63}\text{Cu}_{37}$  films (a) as-sputtered and after treatment for 60 s at +0.5 V in (b) 10 mM  $\text{HNO}_3$ , (c) 20 mM  $\text{HNO}_3$ , and (d) 40 mM  $\text{HNO}_3$ .

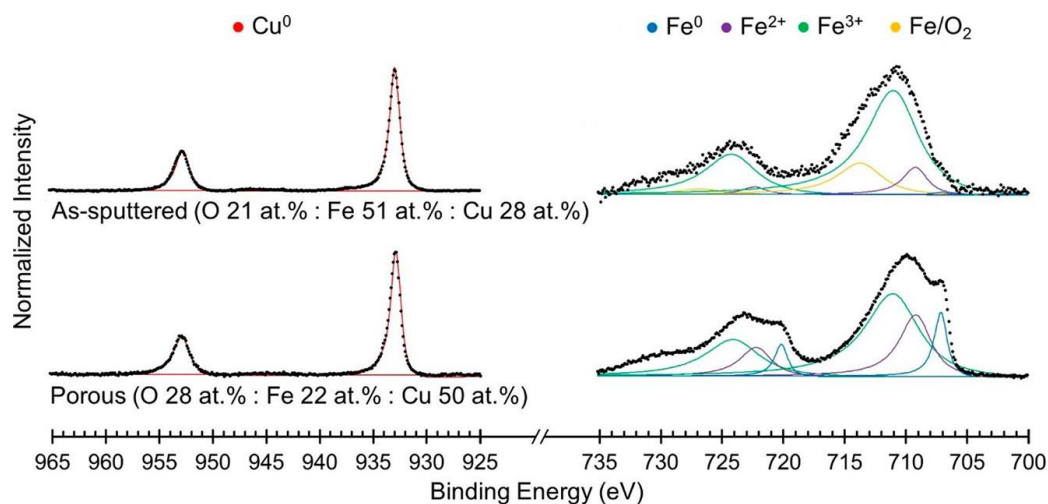


Figure 6. Cu and Fe XPS spectra of high-Fe-content films with fits. Measurements were taken after 15 s of Ar<sup>+</sup> etching to remove surface contaminants. Black dots correspond to raw data points, whereas colored lines are fitted peaks color coded to correspond to oxidation state. Different oxidation states were assigned according to literature reports found using the NIST XPS database.[\(2,5,8,20,35\)](#)

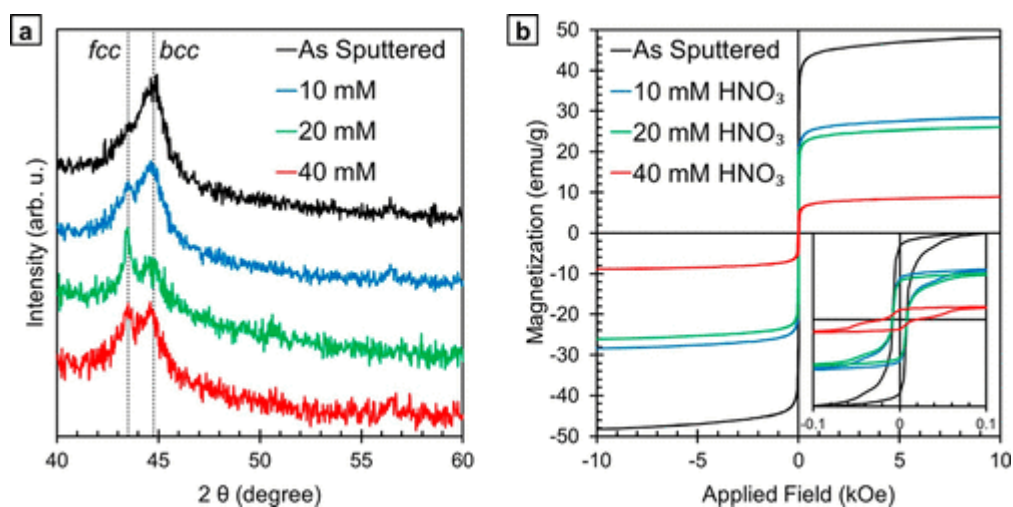


Figure 7. (a) XRD diffractograms of Fe<sub>63</sub>Cu<sub>37</sub> films both as-sputtered (black) and after treatment at +0.5 V for 60 s in various concentrations of nitric acid (10 mM, blue line; 20 mM, green line; 40 mM, red line). (b) In-plane magnetic hysteresis loops of the same films. Inset shows the loops zoomed into the low-applied-field region.

